

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/625,645	CHRISTIAN ET AL.
Examiner	Art Unit	
Leigh C. Maier	1623	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
536	17.2	7/12/2007	LCM
514	62	7/12/2007	LCM